

## CMT-PLA9869 Preliminary Datasheet

Version: 1.0  
(see note 1)

### 1200V/40mOhm SiC MOSFET

#### General description

CMT-PLA9869 is a High Temperature, High Voltage, Silicon Carbide (SiC) MOSFET transistor, available in standard TO-247 package. The product is guaranteed for normal operation over the full range -55°C to +175°C (Tj). The device has a break-down voltage in excess of 1200V and can switch currents up to 60A. The device features a body diode that can be used as free-wheeling diode.

#### Features

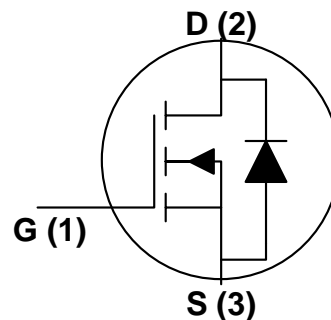
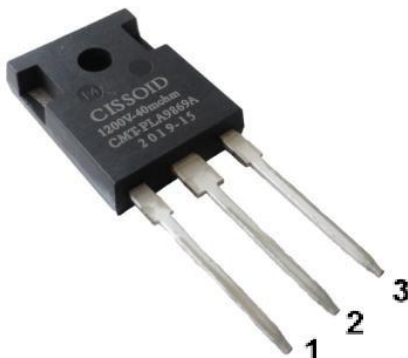
- Specified from -55 to +175°C (Tj)
- $V_{DS}$  Max: 1200V
- $I_{DS}$  @ 25°C: 60 A
- $R_{DS(on)}$ : 40mΩ typ
- Low Switching Energy
  - $E_{on}$ = 1mJ
  - $E_{off}$ = 0.4mJ
- Voltage control:  $V_{GS}$ =-4V/18V
- Gate charge:  $Q_{GS}$ =32nC
- Low capacitance:  $C_{OSS}$ =181 pF
- Package: TO-247 (MSL3)
- Thermal Safe Operation Area model
- RoHS Compliant

#### Benefits

- Increased System Switching Frequency
- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Seamless driving with HADES® gate driver solutions

#### Applications

- Switched-mode Power Supplies
- High Voltage DC-DC converters
- Motor Drives
- Battery Chargers
- Solar Inverters



1 Please always refer to the latest datasheet version available at <http://www.cissoid.com/files/files/products/planet/CMT-PLA9869.pdf>

### Absolute Maximum Ratings

Unless otherwise stated,  $T_j = 25^\circ\text{C}$ . **Bold** figures point out values valid over the whole temperature range ( $T_j = -55^\circ\text{C}$  to  $+175^\circ\text{C}$ ).

Symbol	Parameter	Value	Unit	Test conditions	Note
$V_{DSmax}$	Drain-Source Voltage	1200	V	$V_{GS}=0V, I_D=100\mu A$	
$V_{GSmax}$	Gate-Source Voltage	-10/20	V	Absolute maximum values	
$V_{GSop}$	Gate-Source Voltage	-4/18	V	Recommended operational values	
$I_D$	Continuous Drain Current	60	A	$V_{GS}=20V, T_C=25^\circ\text{C}$	
		40		$V_{GS}=20V, T_C=100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	160	A	Pulse width $t_P$ limited by $T_{jmax}$	
$P_D$	Power Dissipation	330	W	$T_C=25^\circ\text{C}, T_J=150^\circ\text{C}$	
$T_J, T_{stg}$	Operating Junction and Storage Temperature	-55 to +175	$^\circ\text{C}$		
$T_L$	Solder Temperature	260	$^\circ\text{C}$	1.6mm from case for 10s	
$M_d$	Mounting Torque	1	Nm	M3	

### Electrical characteristics

Unless otherwise stated,  $T_j = 25^\circ\text{C}$ . **Bold** figures point out values valid over the whole temperature range ( $T_j = -55^\circ\text{C}$  to  $+175^\circ\text{C}$ ).

Symbol	Parameter	Min	Typ	Max	Unit	Test conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	<b>1200</b>			V	$V_{GS} = -4V, I_D = 100\mu A$	
$V_{GS(th)}$	Gate Threshold Voltage		2.35		V	$V_{DS} = V_{GS}, I_D = 10mA$	
			1.67		V	$V_{DS} = V_{GS}, I_D = 10mA, T_j = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		5		$\mu A$	$V_{DS} = 1200V, V_{GS} = 0V$	
$I_{GSS}$	Gate-Source Leakage Current		10	100	nA	$V_{GS} = 18V, V_{DS} = 0V$	
$R_{DS(on)}$	Drain-Source On-State Resistance		40		$m\Omega$	$V_{GS} = 18V, I_{DS} = 40A$	
			73		$m\Omega$	$V_{GS} = 18V, I_{DS} = 40A, T_j = 175^\circ\text{C}$	
$g_{fs}$	Transconductance		18		S	$V_{DS} = 10V, I_{DS} = 40A$	
			17.6			$V_{DS} = 10V, I_{DS} = 40A, T_j = 175^\circ\text{C}$	
$C_{iss}$	Input capacitance		3367		pF	$V_{GS} = 0V, V_{DS} = 600V, F = 1MHz, V_{AC} = 25mV$	
$C_{oss}$	Output capacitance		181				
$C_{rss}$	Reverse Transfer capacitance		32				
$E_{oss}$	Coss Stored Energy		32				$\mu J$
$E_{ON}$	Turn-On Switching Energy		1		mJ	$V_{DS} = 600V, V_{GS} = -4V/18V, I_D = 40A, R_{G(ext)} = 3\Omega, L = 50\mu H$	
$E_{OFF}$	Turn-Off Switching Energy		0.4		mJ		
$t_{d(on)}$	Turn-On Delay Time		18		ns		$V_{DS} = 600V, V_{GS} = -4V/18V, I_D = 20A, R_{G(ext)} = 3\Omega, L = 400\mu H$ Per IEC60747-8-4 pg 83
$t_r$	Rise Time		55				
$t_{d(off)}$	Turn-Off Delay Time		30				
$t_f$	Fall-Time		36				
$R_{G(int)}$	Internal Gate Resistance		5		$\Omega$	$F = 1MHz, V_{AC} = 25mV$	
$Q_{gs}$	Gate to Source Charge		32		nC	$V_{DS} = 600V, V_{GS} = -4V/18V, I_D = 20A,$ Per IEC60747-8-4 pg 21	
$Q_{gd}$	Gate to Drain Charge		36				
$Q_g$	Total Gate Charge		163				

### Reverse Diode Characteristics

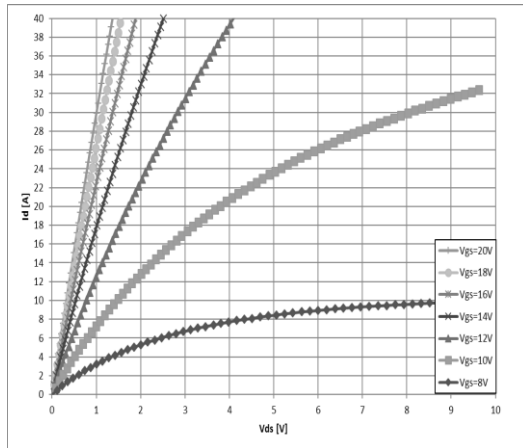
Unless otherwise stated,  $T_j = 25^\circ\text{C}$ . **Bold** figures point out values valid over the whole temperature range ( $T_j = -55^\circ\text{C}$  to  $+175^\circ\text{C}$ ). Timing definitions according to JEDEC 24 page 27

Symbol	Parameter	Min	Typ	Max	Unit	Test conditions	Note
$V_{SD}$	Diode Forward Voltage		5.2		V	$V_{GS} = -5V, I_{SD} = 20A, T_j = 25^\circ\text{C}$	
			4.4		V	$V_{GS} = -5V, I_{SD} = 20A, T_j = 175^\circ\text{C}$	
$I_S$	Continuous Diode Forward Current		60		A	$T_C = 25^\circ\text{C}$	
$t_{rr}$	Reverse Recovery Time		27		ns	$V_{GS} = -5V, I_{SD} = 40A, T_j = 25^\circ\text{C}, V_R = 600V, dif/dt = 2500A/\mu s$	
$Q_{rr}$	Reverse Recovery Charge		170		nC		
$I_{rr}$	Peak Reverse Recovery Current		9.6		A		

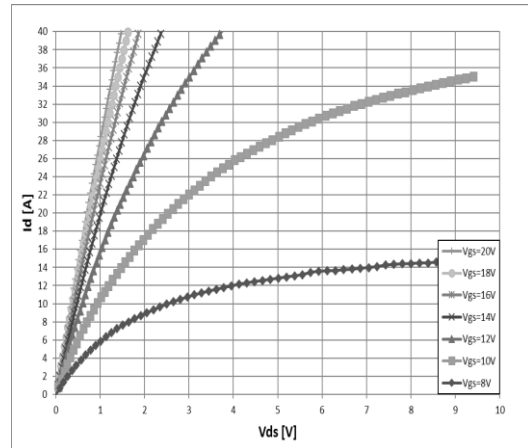
### Thermal Characteristics

Symbol	Parameter	Min	Typ	Max	Unit	Test conditions	Note
$R_{\theta JC}$	Thermal Resistance Junction to Case		0.33	0.38	$^\circ\text{C/W}$		

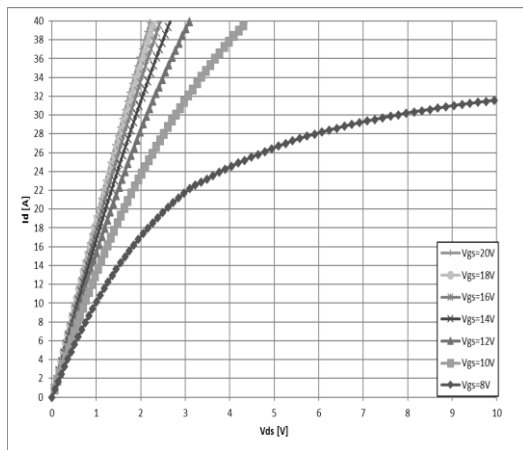
### Typical Performance Characteristics



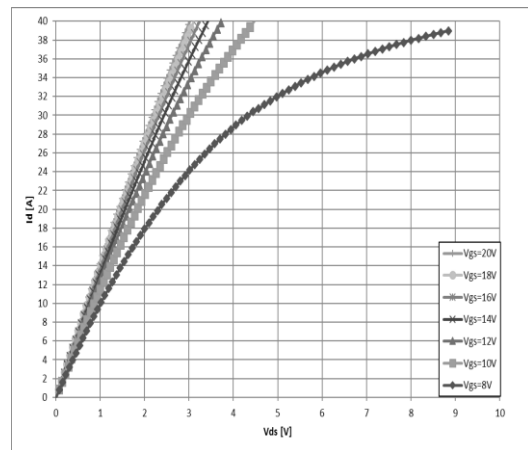
**Figure 1:** Drain current vs  $V_{DS}$  ( $T_j=-40^\circ\text{C}$ )



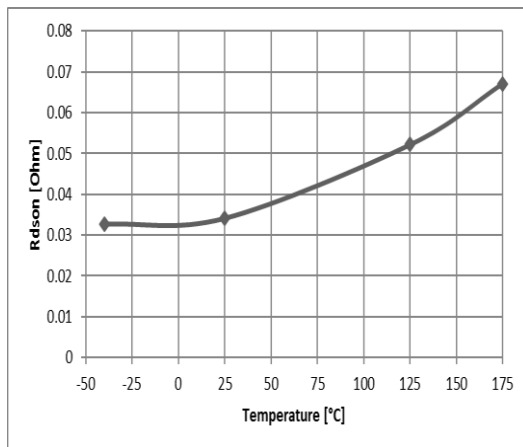
**Figure 2:** Drain current vs  $V_{DS}$  ( $T_j=25^\circ\text{C}$ )



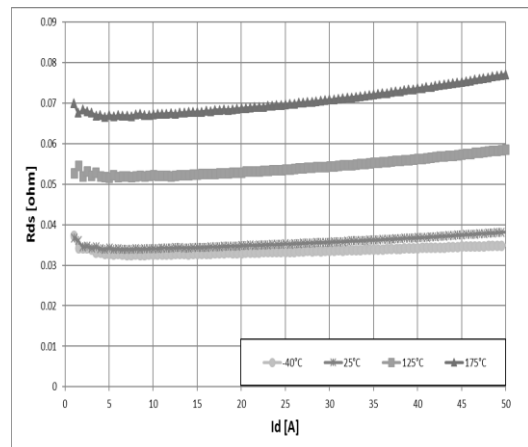
**Figure 3:** Drain current vs  $V_{DS}$  ( $T_j=125^\circ\text{C}$ )



**Figure 4:** Drain current vs  $V_{DS}$  ( $T_j=175^\circ\text{C}$ )

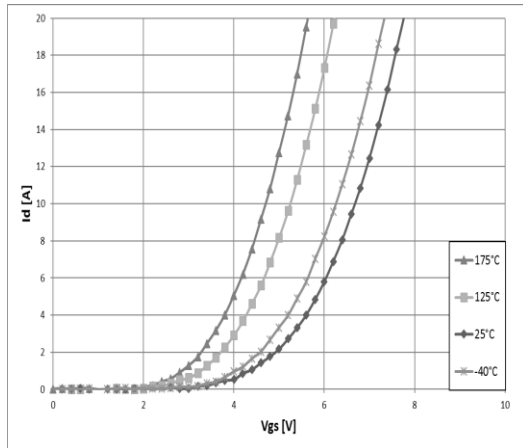


**Figure 5:** On-state drain source resistance vs. Temperature ( $V_{GS} =20\text{V}$ ;  $I_{DS}=10\text{A}$ )

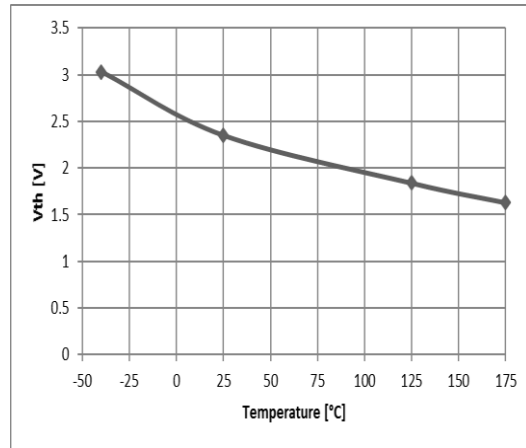


**Figure 6:** On-state drain source resistance vs. Drain current and temperature ( $V_{GS} =20\text{V}$ )

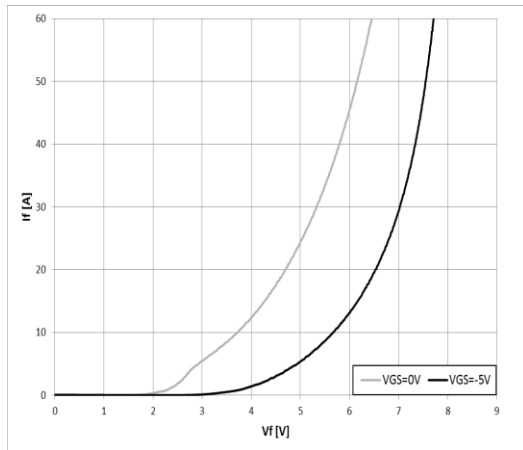
**Typical Performance Characteristics (cnt'd)**



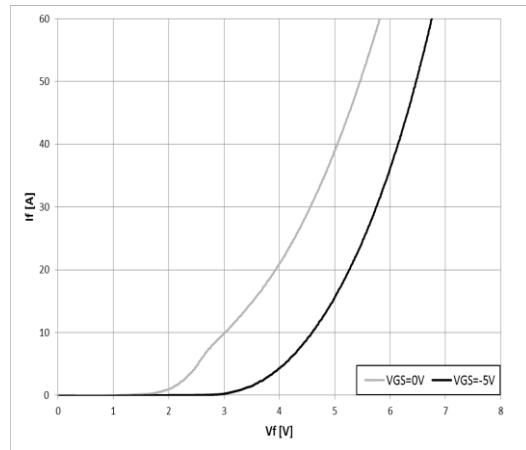
**Figure 7:** Drain current vs  $V_{GS}$   
( $V_{DS}= 10V$ )



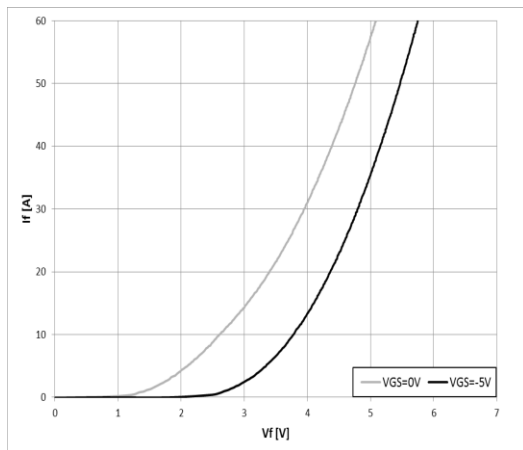
**Figure 8:** Threshold voltage vs temperature



**Figure 9:** Body diode  $I_F$  vs  $V_F$  at  $-55^\circ C$

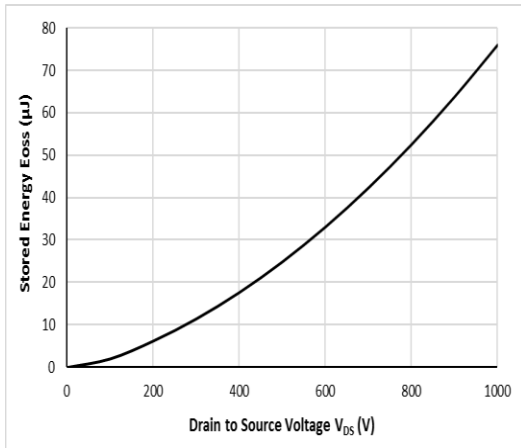


**Figure 10:** Body diode  $I_F$  vs  $V_F$  at  $25^\circ C$

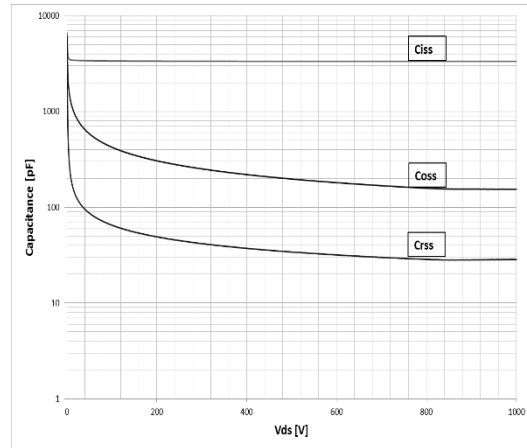


**Figure 11:** Body diode  $I_F$  vs  $V_F$  at  $175^\circ C$

**Typical Performance Characteristics (cnt'd)**

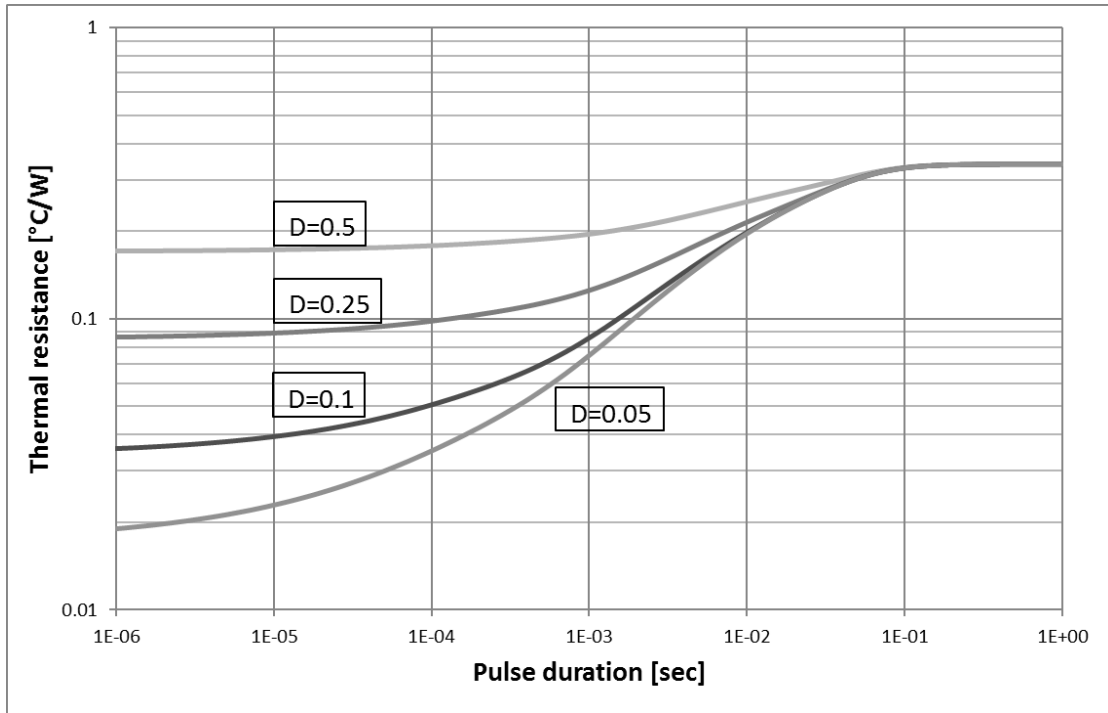


**Figure 12:** Output Capacitor Stored Energy

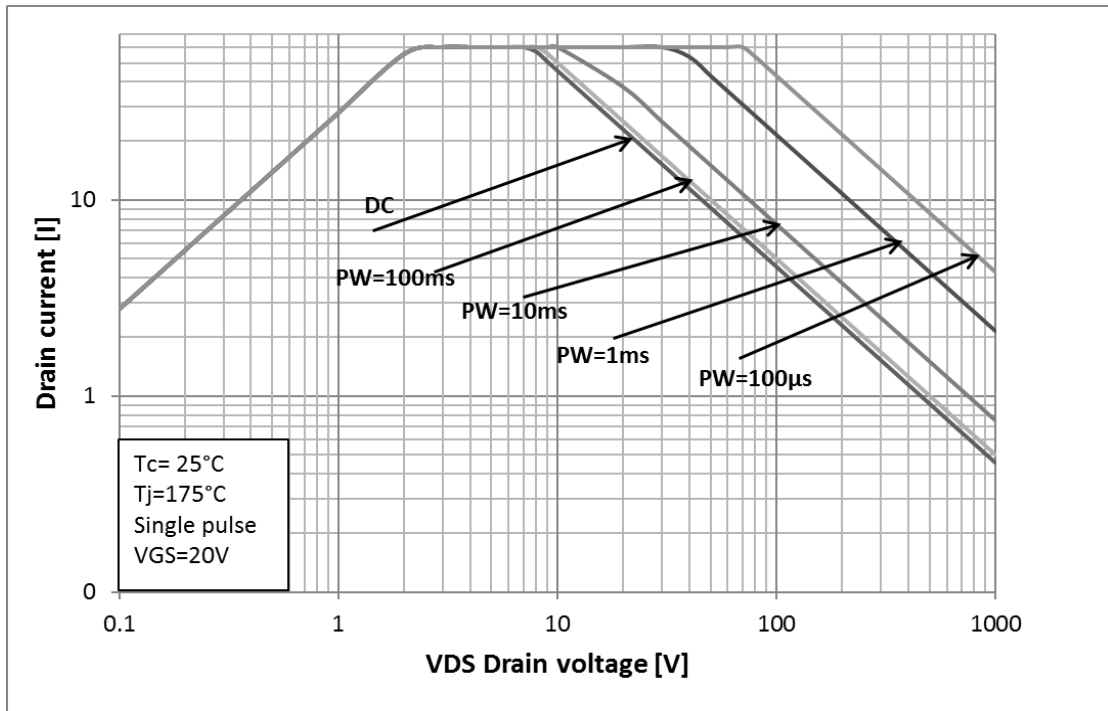


**Figure 13:** Capacitances vs  $V_{DS}$  ( $T_j=25^\circ\text{C}$ )

**Typical Performance Characteristics (cnt'd)**



**Figure 14: Transient thermal resistance**



**Figure 15: Safe Operating Area**

## Thermal Safe Operating Area

In power electronics, thermal design is an essential part of the design process. CMT-PLA9869 device junction-to-case thermal resistance,  $R_{th,j-c}$  is very low ( $0.33^{\circ}\text{C/W}$ ). However, when designing the system, one needs to consider the end-to-end junction-to-air thermal resistance which can be evaluated using FEA tools or physical measurements. With too high a thermal resistance, it is possible that any power device will experience thermal runaway. This situation should of course be avoided as it leads to the device destruction.

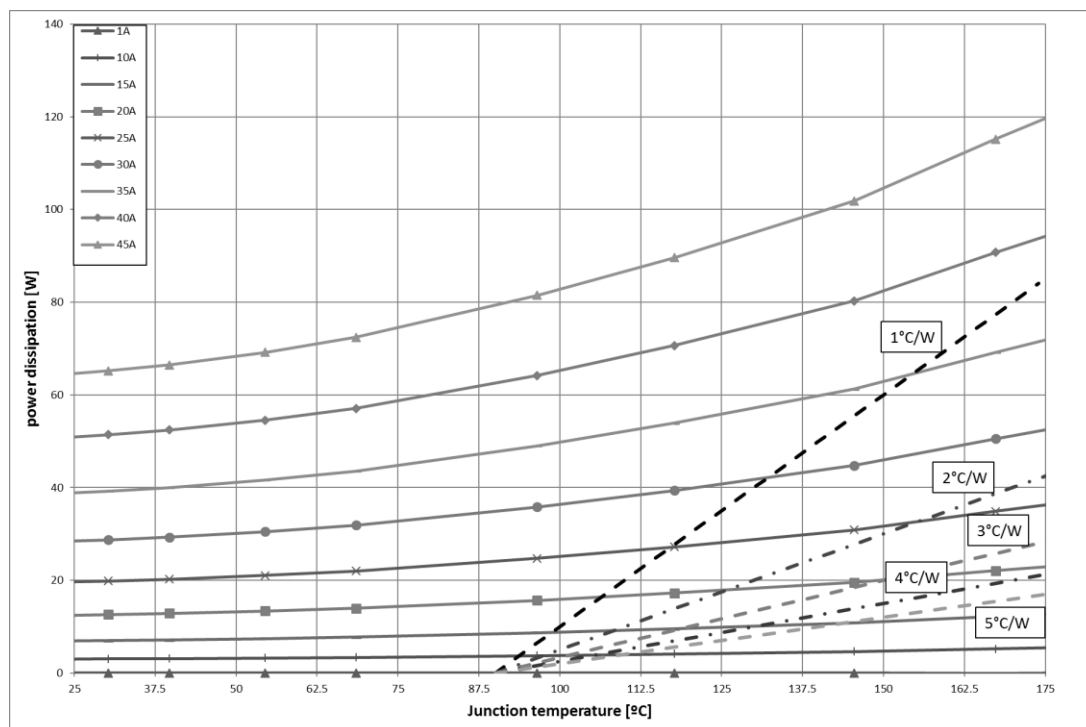
The graph below will help system designers to dimension their system properly. Firstly, it plots the device resistive losses as a function of temperature for different DC currents. Since  $R_{ds(on)}$  increases with temperature, power dissipation increases with temperature as well. The curves do not include the dissipation due to switching losses which tends to be quite flat over the entire temperature range so therefore an offset may be applied to the curves to take it into account.

Secondly, it plots (in dotted lines) the behavior of the thermal system: the room temperature (point crossing the X-axis at zero power) at which the system operates (e.g.  $T_a=90^{\circ}\text{C}$  in the graph example below) and the global junction-to-air thermal resistance (the slope of the straight lines).

To have a stable and healthy system, one needs to ensure that the dotted line (corresponding to the designed thermal system) and the relevant (function of the DC current flowing through the device) power dissipation line are crossing each other at a temperature point below the recommended maximum junction operating point of the device.

As examples:

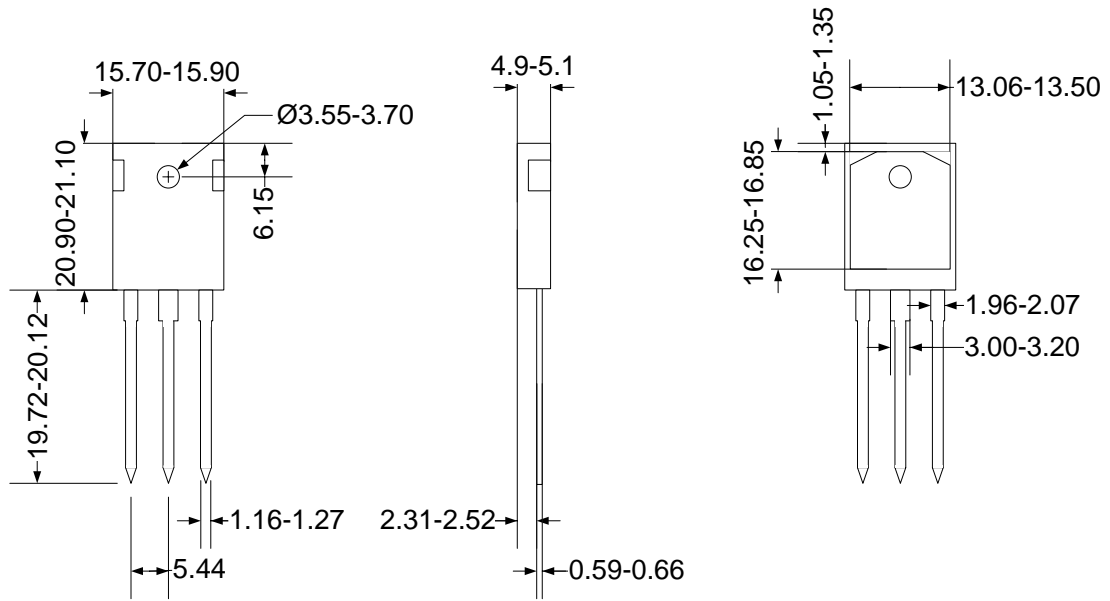
- With a system thermal resistance of  $3^{\circ}\text{C/W}$ , using CMT-PLA9869 with any DC current above 20A will lead a junction temperature outside of the recommended conditions.
- With a system thermal resistance of  $1^{\circ}\text{C/W}$ , up to 35A DC current can be used.



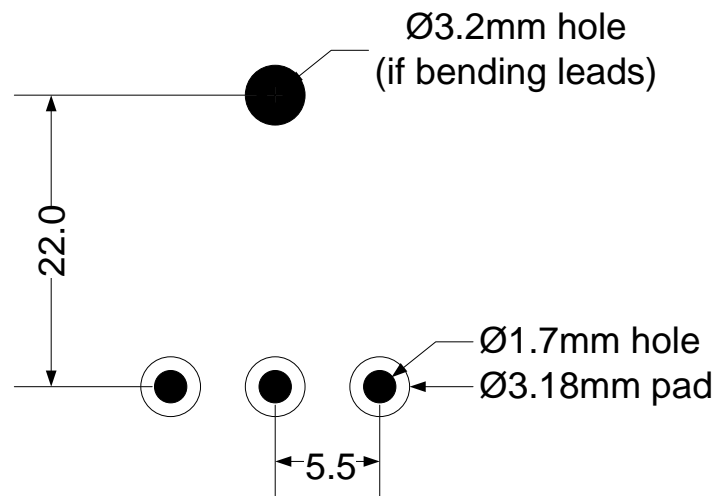
**Figure 16: Thermal Safe Operating Area**



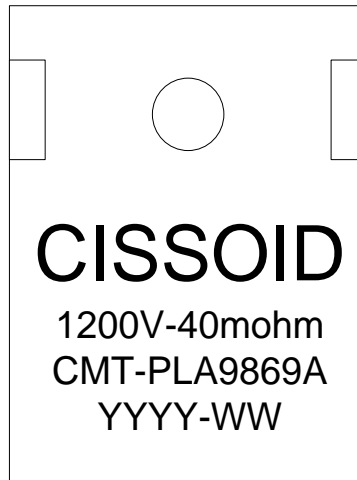
### Package Dimension



### Suggested PCB Pad Layout



### Marking information



YYYY	Year
WW	Week (1 to 53)

### Ordering Information

Product Name	Ordering Reference	Package	Marking
CMT-PLA9869	CMT-PLA9869A-TO247	TO-247	CHT-PLA9869A

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## Contact & Ordering

### CISSOID S.A.

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